

## LM185-1.2QMLLM185-1.2QML Micropower Voltage Reference Diode

Check for Samples: [LM185-1.2QML](#)

### FEATURES

- **Operating Current of 10 $\mu$ A to 20mA**
- **1 $\Omega$  Maximum Dynamic Impedance (Typical)**
- **Low Temperature Coefficient**
- **Low Voltage Reference - 1.235V**

### DESCRIPTION

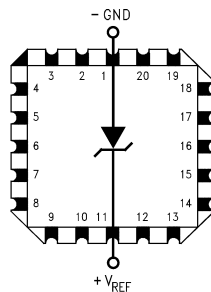
The LM185-1.2 is a micropower 2-terminal band-gap voltage regulator diodes. Operating over a 10 $\mu$ A to 20mA current range, it features exceptionally low dynamic impedance and good temperature stability. On-chip trimming is used to provide tight voltage tolerance. Since the LM185-1.2 band-gap reference uses only transistors and resistors, low noise and good long term stability result.

Careful design of the LM185-1.2 has made the device exceptionally tolerant of capacitive loading, making it easy to use in almost any reference application. The wide dynamic operating range allows its use with widely varying supplies with excellent regulation.

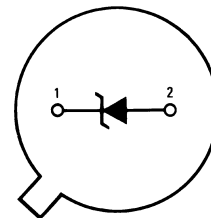
The extremely low power drain of the LM185-1.2 makes it useful for micropower circuitry. This voltage reference can be used to make portable meters, regulators or general purpose analog circuitry with battery life approaching shelf life.

Further, the wide operating current allows it to replace older references with a tighter tolerance part.

### Connection Diagrams



**Figure 1. LCCC Package**  
See Package Number NAJ0020A

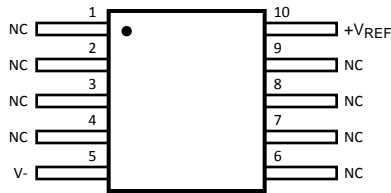


**Figure 2. TO Package – Bottom View**  
See Package Number NDU0002A



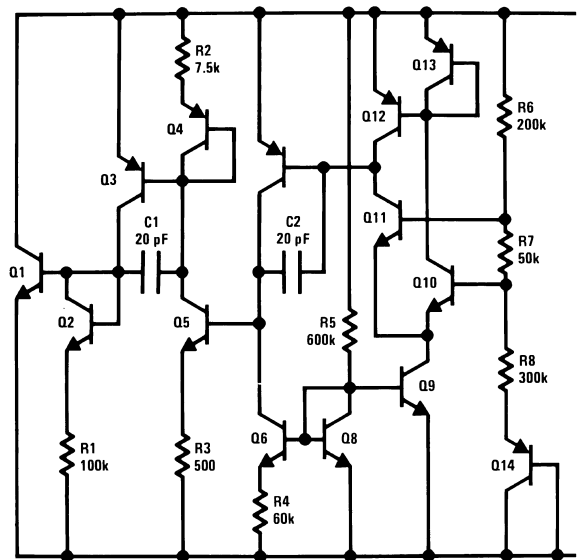
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**Figure 3. CLGA Package**  
See Package Number NAC0010A

**Schematic Diagram**



These devices have limited built-in ESD protection. The leads should be shorted together or the device placed in conductive foam during storage or handling to prevent electrostatic damage to the MOS gates.

**Absolute Maximum Ratings<sup>(1)</sup>**

Reverse Current		30mA	
Forward Current		10mA	
Operating Temperature Range		-55°C ≤ T <sub>A</sub> ≤ +125°C	
Maximum Junction Temperature (T <sub>Jmax</sub> ) <sup>(2)</sup>		+150°C	
Storage Temperature		-55°C ≤ T <sub>A</sub> ≤ +150°C	
Lead Temperature (Soldering 10 Seconds)	CLGA	260°C	
	TO package	300°C	
	20LD LCCC package	300°C	
Thermal Resistance	θ <sub>JA</sub>	TO (Still Air)	300°C/W
		TO (500LF / Min Air Flow)	139°C/W
		20LD LCCC (Still Air)	100°C/W
		20LD LCCC (500LF / Min Air Flow)	73°C/W
		CLGA (Still Air)	194°C/W
		CLGA (500LF / Min Air Flow)	128°C/W
	θ <sub>JC</sub>	TO	57°C/W
		20LD LCCC	25°C/W
		CLGA	23°C/W
Package Weight (Typical)	TO	TBD	
	20LD LCCC	TBD	
	CLGA	210mg	
ESD Tolerance <sup>(3)</sup>		4KV	

- (1) Absolute Maximum Ratings indicate limits beyond which damage to the device may occur. Operating Ratings indicate conditions for which the device is functional, but do not guarantee specific performance limits. For guaranteed specifications and test conditions, see the Electrical Characteristics. The guaranteed specifications apply only for the test conditions listed. Some performance characteristics may degrade when the device is not operated under the listed test conditions.
- (2) The maximum power dissipation must be derated at elevated temperatures and is dictated by T<sub>Jmax</sub> (maximum junction temperature), θ<sub>JA</sub> (package junction to ambient thermal resistance), and T<sub>A</sub> (ambient temperature). The maximum allowable power dissipation at any temperature is P<sub>Dmax</sub> = (T<sub>Jmax</sub> - T<sub>A</sub>)/θ<sub>JA</sub> or the number given in the Absolute Maximum Ratings, whichever is lower.
- (3) Human body model, 1.5KΩ in series with 100pF.

**Quality Conformance Inspection**
**Table 1. Mil-Std-883, Method 5005 - Group A**

Subgroup	Description	Temp °C
1	Static tests at	25
2	Static tests at	125
3	Static tests at	-55
4	Dynamic tests at	25
5	Dynamic tests at	125
6	Dynamic tests at	-55
7	Functional tests at	25
8A	Functional tests at	125
8B	Functional tests at	-55
9	Switching tests at	25
10	Switching tests at	125
11	Switching tests at	-55
12	Settling time at	25
13	Settling time at	125
14	Settling time at	-55

### LM185–1.2 Electrical Characteristics DC Parameters

Symbol	Parameter	Conditions	Notes	Min	Max	Units	Sub-groups
$V_{Ref}$	Reverse Breakdown Voltage	$I_R = 10\mu A$		1.223	1.247	V	1
		$I_R = 20\mu A$		1.205	1.26	V	2, 3
		$I_R = 1mA$		1.223	1.247	V	1
				1.205	1.26	V	2, 3
		$I_R = 20mA$		1.223	1.247	V	1
	1.205		1.26	V	2, 3		
$\Delta V_{Ref} / \Delta I_R$	Reverse Breakdown Voltage Change with Current	$10\mu A \leq I_R \leq 1mA$		-1.0	1.0	mV	1
		$20\mu A \leq I_R \leq 1mA$		-1.5	1.5	mV	2, 3
		$1mA \leq I_R \leq 20mA$		-10.0	10.0	mV	1
				-20.0	20.0	mV	2, 3
$V_F$	Forward Bias Voltage	$I_F = 2mA$		-1.0	-0.4	V	1

### LM185–1.2 Electrical Characteristics DC Drift Parameters

Delta calculations performed on QMLV devices at group B, subgroup 5, unless otherwise specified on the IPI.

Symbol	Parameter	Conditions	Notes	Min	Max	Units	Sub-groups
$V_R$	Reverse Breakdown Voltage	$I_R = 10\mu A$		-0.01	0.01	V	1
		$I_R = 20mA$		-0.01	0.01	V	1

### LM185BY–1.2 Electrical Characteristics DC Parameters

Symbol	Parameter	Conditions	Notes	Min	Max	Units	Sub-groups
$V_{Ref}$	Reverse Breakdown Voltage	$I_R = 10\mu A$		1.22 3	1.24 7	V	1
		$I_R = 20\mu A$		1.20 5	1.26	V	2, 3
		$I_R = 1mA$		1.22 3	1.24 7	V	1
				1.20 5	1.26	V	2, 3
		$I_R = 20mA$		1.22 3	1.24 7	V	1
	1.20 5		1.26	V	2, 3		
$\Delta V_{Ref} / \Delta I_R$	Reverse Breakdown Voltage Change with Current	$10\mu A \leq I_R \leq 1mA$		-1.0	1.0	mV	1
		$20\mu A \leq I_R \leq 1mA$		-1.5	1.5	mV	2, 3
		$1mA \leq I_R \leq 20mA$		-10.0	10.0	mV	1
				-20.0	20.0	mV	2, 3
$V_F$	Forward Bias Voltage	$I_F = 2mA$		-1.0	-0.4	V	1
$T_C$	Temperature Coefficient		See <sup>(1)</sup>		50	PPM/°C	2, 3

- (1) The average temperature coefficient is defined as the maximum deviation of reference voltage, at all measured temperatures between the operating  $T_{Min}$  &  $T_{Max}$ , divided by  $(T_{Max} - T_{Min})$ . The measured temperatures ( $T_{Measured}$ ) are  $-55^\circ C$ ,  $25^\circ C$ , &  $125^\circ C$  or  $\Delta V_{Ref} / (T_{Max} - T_{Min})$

Typical Performance Characteristics

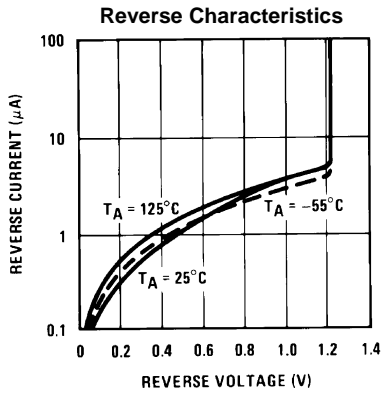


Figure 4.

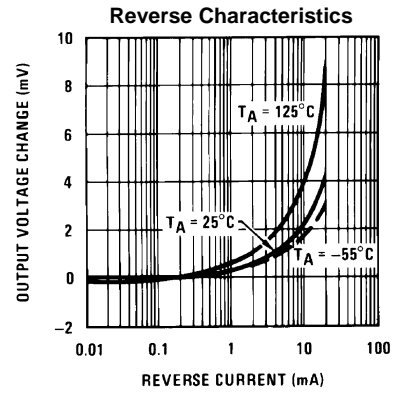


Figure 5.

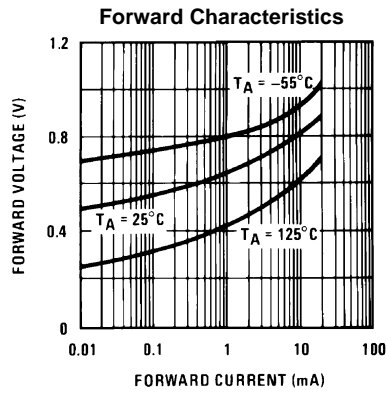


Figure 6.

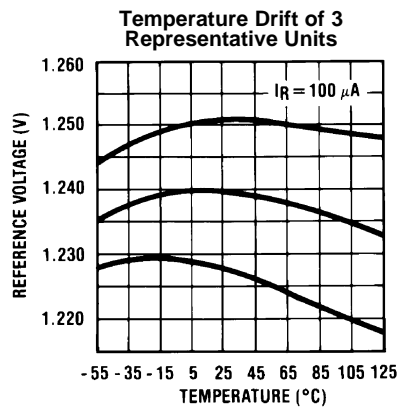


Figure 7.

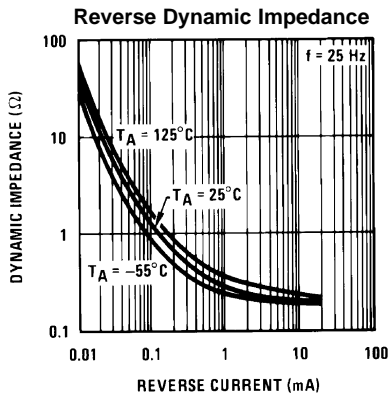


Figure 8.

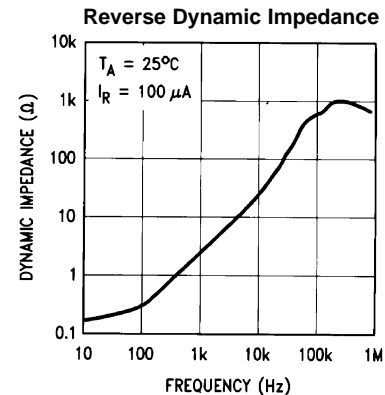


Figure 9.

Typical Performance Characteristics (continued)

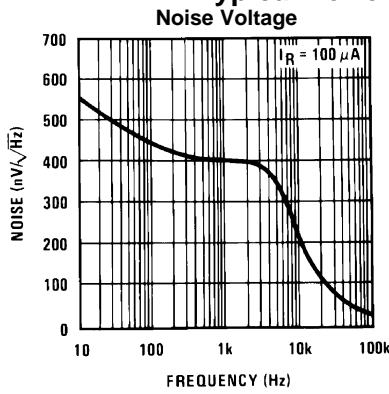


Figure 10.

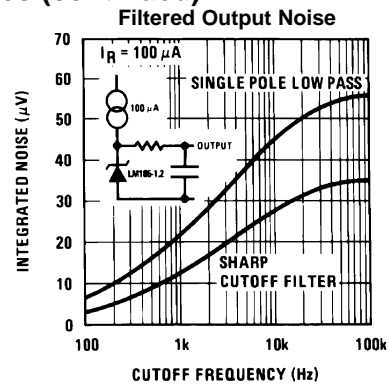


Figure 11.

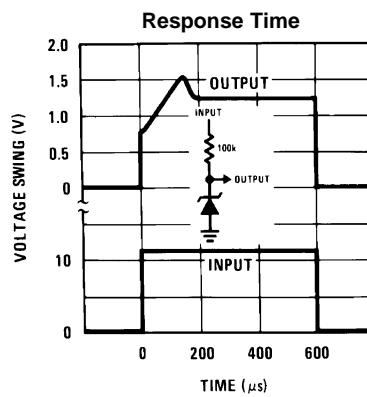


Figure 12.

Typical Applications

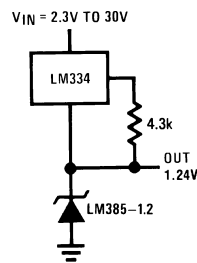


Figure 13. Wide Input Range Reference

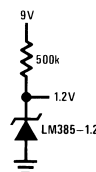


Figure 14. Micropower Reference from 9V Battery

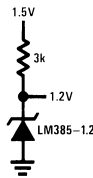
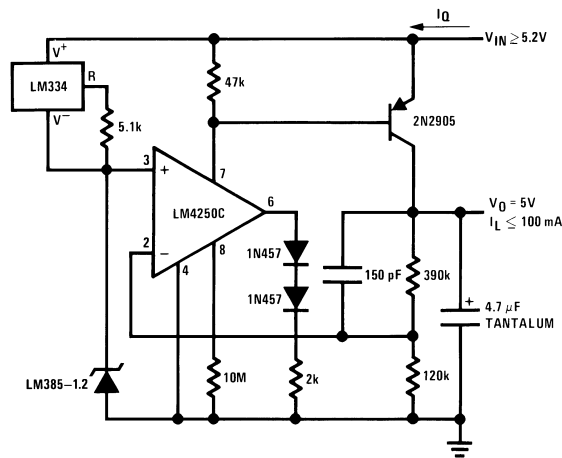
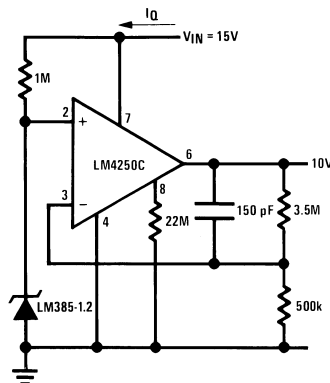


Figure 15. Reference from 1.5V Battery



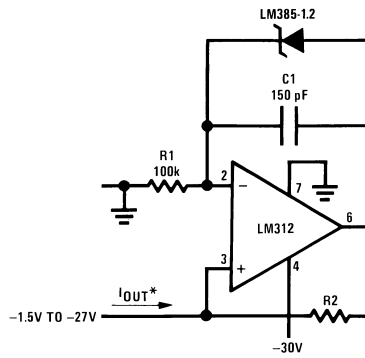
\* $I_Q \approx 30\mu A$

Figure 16. Micropower\* 5V Regulator



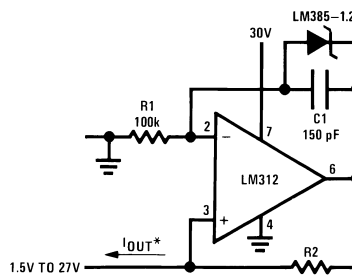
\* $I_Q \approx 20\mu A$  standby current

Figure 17. Micropower\* 10V Reference

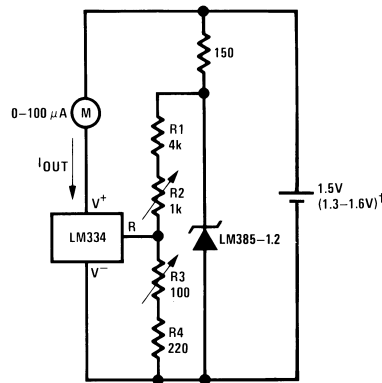


$$*I_{OUT} = \frac{1.23V}{R2}$$

Figure 18. Precision 1µA to 1mA Current Sources



METER THERMOMETERS

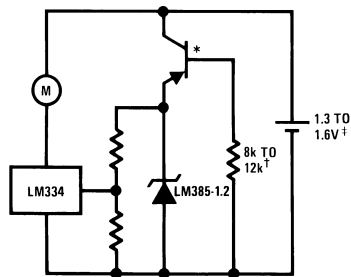


Calibration

1. Short LM385-1.2, adjust R3 for I<sub>OUT</sub>= temp at 1µA/°K
  2. Remove short, adjust R2 for correct reading in centigrade
- †I<sub>Q</sub> at 1.3V=500µA  
I<sub>Q</sub> at 1.6V=2.4mA

Figure 19. 0°C–100°C Thermometer



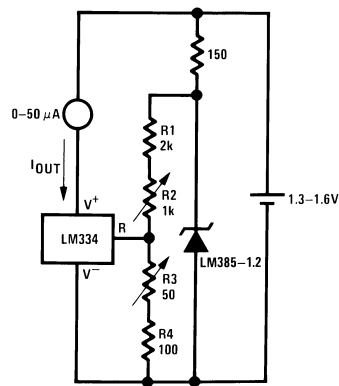


\*2N3638 or 2N2907 select for inverse  $H_{FE} \approx 5$

†Select for operation at 1.3V

‡ $I_Q \approx 600\mu\text{A}$  to  $900\mu\text{A}$

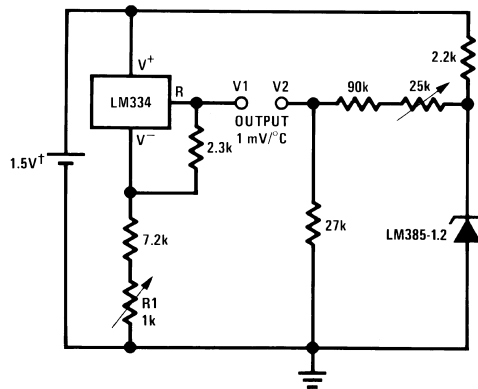
Figure 20. Lower Power Thermometer



**Calibration**

1. Short LM385-1.2, adjust R3 for  $I_{OUT} = \text{temp}$  at  $1.8\mu\text{A}/^\circ\text{K}$
2. Remove short, adjust R2 for correct reading in  $^\circ\text{F}$

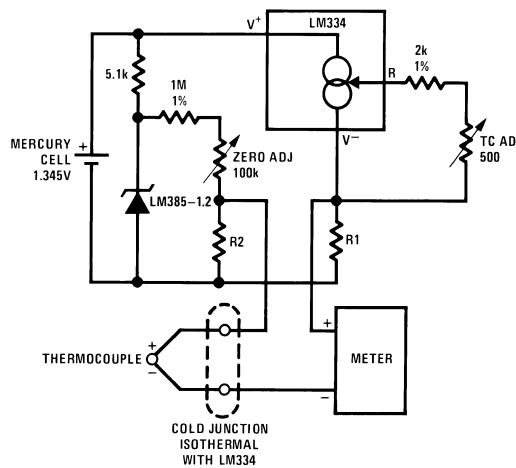
Figure 21.  $0^\circ\text{F}$ – $50^\circ\text{F}$  Thermometer



**Calibration**

1. Adjust R1 so that V1 = temp at 1mV/°K
  2. Adjust V2 to 273.2mV
- $I_Q$  for 1.3V to 1.6V battery voltage = 50µA to 150µA

**Figure 22. Centigrade Thermometer**



**Adjustment Procedure**

1. Adjust TC ADJ pot until voltage across R1 equals Kelvin temperature multiplied by the thermocouple Seebeck coefficient.
2. Adjust zero ADJ pot until voltage across R2 equals the thermocouple Seebeck coefficient multiplied by 273.2.

**Figure 23. Micropower Thermocouple Cold Junction Compensator**

Thermocouple Type	Seebeck Coefficient (µV/°C)	R1 (Ω)	R2 (Ω)	Voltage Across R1 @ 25°C (mV)	Voltage Across R2 (mV)
J	52.3	523	1.24k	15.60	14.32
T	42.8	432	1k	12.77	11.78
K	40.8	412	953Ω	12.17	11.17
S	6.4	63.4	150Ω	1.908	1.766

Typical supply current 50 $\mu$ A

**REVISION HISTORY SECTION**

Released	Revision	Section	Originator	Changes
10/07/05	A	New Release, Corporate format	L. Lytle	2 MDS data sheets converted into one Corp. data sheet format. MNLM185-1.2-X Rev 2A3 and MNLM185BY-1.2-X Rev 0B0 data sheets will be archived.

**PACKAGING INFORMATION**

Orderable Device	Status (1)	Package Type	Package Drawing	Pins	Package Qty	Eco Plan (2)	Lead/Ball Finish	MSL Peak Temp (3)	Op Temp (°C)	Top-Side Markings (4)	Samples
5962-8759401VXA	ACTIVE	TO	NDU	2	20	TBD	Call TI	Call TI	-55 to 125	8759401VXA Q	<a href="#">Samples</a>
5962-8759401VYA	ACTIVE	CLGA	NAC	10	54	TBD	Call TI	Call TI	-55 to 125	LM185WG -1.2-QV Q 5962-87594 01VYA ACO 01VYA >T	<a href="#">Samples</a>
5962-8759401XA	ACTIVE	TO	NDU	2	20	TBD	Call TI	Call TI	-55 to 125	8759401XA Q	<a href="#">Samples</a>
5962-8759401YA	ACTIVE	CLGA	NAC	10	54	TBD	Call TI	Call TI	-55 to 125	LM185WG -1.2/883 Q 5962-87594 01YA ACO 01YA >T	<a href="#">Samples</a>
5962-8759405XA	ACTIVE	TO	NDU	2	20	TBD	Call TI	Call TI	-55 to 125	8759405XA Q	<a href="#">Samples</a>
LM185BYH1.2-SMD	ACTIVE	TO	NDU	2	20	TBD	Call TI	Call TI	-55 to 125	8759405XA Q	<a href="#">Samples</a>
LM185H-1.2-QV	ACTIVE	TO	NDU	2	20	TBD	Call TI	Call TI	-55 to 125	8759401VXA Q	<a href="#">Samples</a>
LM185H-1.2-SMD	ACTIVE	TO	NDU	2	20	TBD	Call TI	Call TI	-55 to 125	8759401XA Q	<a href="#">Samples</a>
LM185H-1.2/883	ACTIVE	TO	NDU	2	20	TBD	Call TI	Call TI	-55 to 125	LM185-1.2 Q	<a href="#">Samples</a>
LM185WG-1.2-QV	ACTIVE	CLGA	NAC	10	54	TBD	Call TI	Call TI	-55 to 125	LM185WG -1.2-QV Q 5962-87594 01VYA ACO 01VYA >T	<a href="#">Samples</a>
LM185WG-1.2/883	ACTIVE	CLGA	NAC	10	54	TBD	Call TI	Call TI	-55 to 125	LM185WG -1.2/883 Q 5962-87594 01YA ACO 01YA >T	<a href="#">Samples</a>

(1) The marketing status values are defined as follows:

**ACTIVE:** Product device recommended for new designs.

**LIFEBUY:** TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

**NRND:** Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

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**PREVIEW:** Device has been announced but is not in production. Samples may or may not be available.

**OBSOLETE:** TI has discontinued the production of the device.

<sup>(2)</sup> Eco Plan - The planned eco-friendly classification: Pb-Free (RoHS), Pb-Free (RoHS Exempt), or Green (RoHS & no Sb/Br) - please check <http://www.ti.com/productcontent> for the latest availability information and additional product content details.

**TBD:** The Pb-Free/Green conversion plan has not been defined.

**Pb-Free (RoHS):** TI's terms "Lead-Free" or "Pb-Free" mean semiconductor products that are compatible with the current RoHS requirements for all 6 substances, including the requirement that lead not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, TI Pb-Free products are suitable for use in specified lead-free processes.

**Pb-Free (RoHS Exempt):** This component has a RoHS exemption for either 1) lead-based flip-chip solder bumps used between the die and package, or 2) lead-based die adhesive used between the die and leadframe. The component is otherwise considered Pb-Free (RoHS compatible) as defined above.

**Green (RoHS & no Sb/Br):** TI defines "Green" to mean Pb-Free (RoHS compatible), and free of Bromine (Br) and Antimony (Sb) based flame retardants (Br or Sb do not exceed 0.1% by weight in homogeneous material)

<sup>(3)</sup> MSL, Peak Temp. -- The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

<sup>(4)</sup> Only one of markings shown within the brackets will appear on the physical device.

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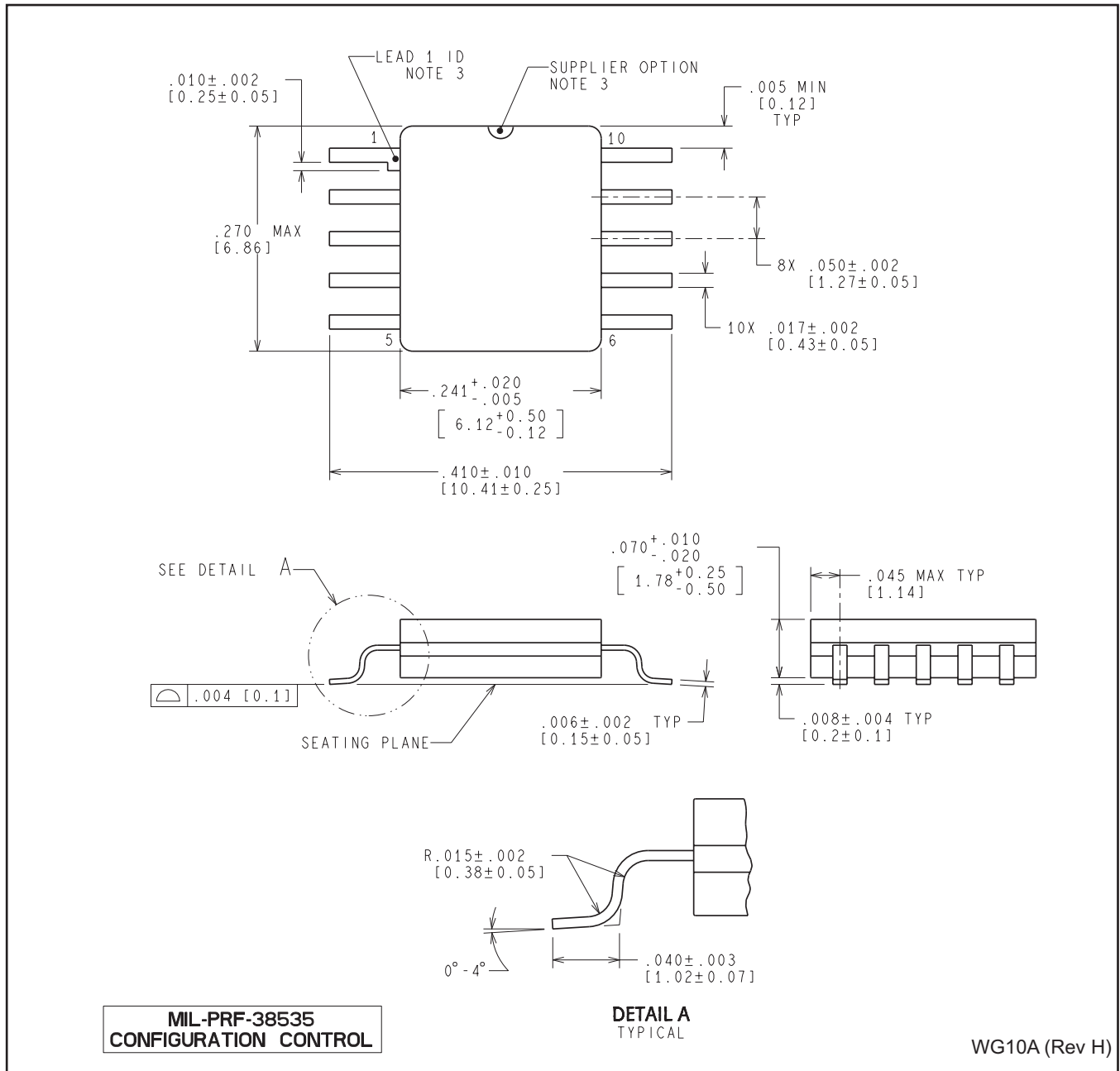
**OTHER QUALIFIED VERSIONS OF LM185-1.2QML, LM185-1.2QML-SP :**

- Military: [LM185-1.2QML](#)
  
- Space: [LM185-1.2QML-SP](#)

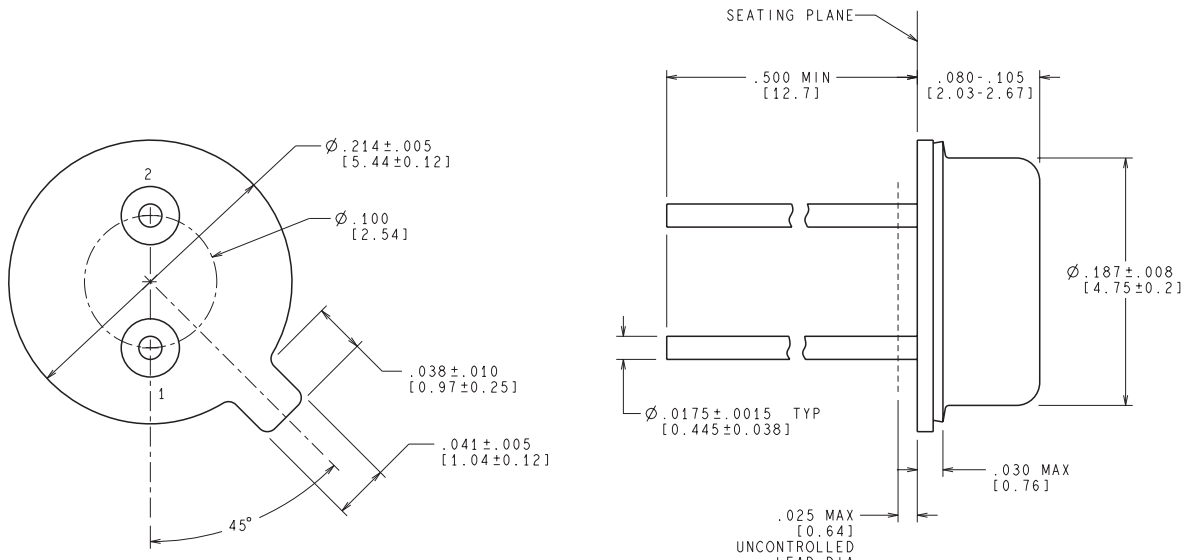
NOTE: Qualified Version Definitions:

- Military - QML certified for Military and Defense Applications
  
- Space - Radiation tolerant, ceramic packaging and qualified for use in Space-based application

NAC0010A



NDU0002A



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H02A (Rev F)

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TI has specifically designated certain components as meeting ISO/TS16949 requirements, mainly for automotive use. In any case of use of non-designated products, TI will not be responsible for any failure to meet ISO/TS16949.

### Products

Audio	<a href="http://www.ti.com/audio">www.ti.com/audio</a>
Amplifiers	<a href="http://amplifier.ti.com">amplifier.ti.com</a>
Data Converters	<a href="http://dataconverter.ti.com">dataconverter.ti.com</a>
DLP® Products	<a href="http://www.dlp.com">www.dlp.com</a>
DSP	<a href="http://dsp.ti.com">dsp.ti.com</a>
Clocks and Timers	<a href="http://www.ti.com/clocks">www.ti.com/clocks</a>
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